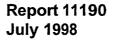
115 652 -





GENCORP AEROJET

Integrated Advanced Microwave Sounding Unit-A (AMSU-A)

Performance Verification Report
Subassembly and Complete Instrument Assembly
METSAT AMSU-A2 Antenna Drive Subassembly,
P/N 1331200-2, S/N 105

Contract No. NAS 5-32314 CDRL 208

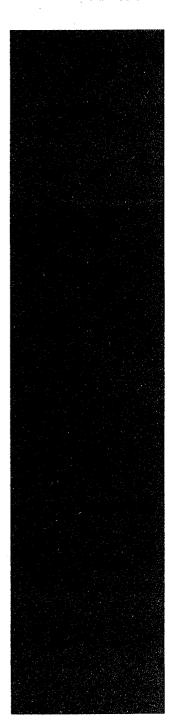
Submitted to:

National Aeronautics and Space Administration Goddard Space Flight Center Greenbelt, Maryland 20771

Submitted by:

Aerojet 1100 West Hollyvale Street Azusa, California 91702

**Aerojet** 



Report 11190 July 1998

Integrated Advanced Microwave Sounding Unit-A (AMSU-A)

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## AMSU-A VERIFICATION TEST REPORT

TEST ITEM:

METSAT AMSU- A2 ANTENNA DRIVE

SUBSYSTEM

PART OF P/N: 1331200-2 SERIAL NUMBER: 105

LEVEL OF ASSEMBLY:

SUBASSEMBLY AND COMPLETE INSTRUMENT

**ASSEMBLY** 

TYPE HARDWARE:

**FLIGHT** 

VERIFICATION: PROCEDURE NO.

AE-26002/2C

TEST DATE:

ASSEMBLIES:

SUBSYSTEM:

START DATE:

12 May 1998

START DATE:

17 June 1998

## TABLE OF CONTENTS

## **ITEM**

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5.2	CIRCUIT CARD ASSEMBLIES
5.3	SIGNAL PROCESSOR
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5.5	ANTENNA AND COMPENSATOR DRIVE SUBSYSTEM TESTS
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5.5.4	GAIN/PHASE MARGIN
5.5.5	OPERATIONAL GAIN MARGIN
6.0	CONCLUSIONS AND RECOMMENDATIONS
7.0	TEST DATA

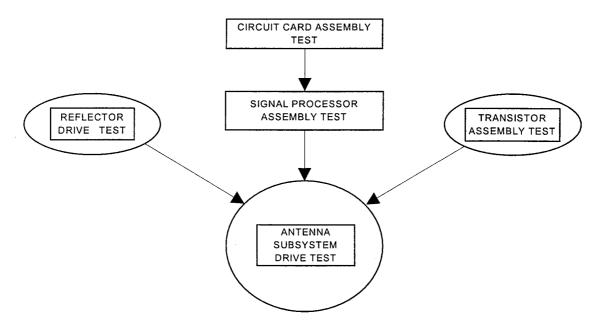
### 1.0 INTRODUCTION

An antenna drive subsystem test was performed on the METSAT AMSU-A2 S/N 105 instrument. The objective of the test was to demonstrate compliance with applicable paragraphs of AMSU-A specifications S-480-80. Tests were conducted at both the subassembly and instrument level.

#### 2.0 SUMMARY

The antenna drive subsystem of the METSAT AMSU-A2 S/N 105, P/N 1331200-2, completed acceptance testing per AES Test Procedure AE-26002/2C. The test included: Scan Motion and Jitter, Noisy Bus Peak Current and Rise Time, Resolver Reading and Position Error, Gain/ Phase Margin, and Operational Gain Margin.

The drive motor and electronic circuitry were also tested at the component level. The drive motor test includes: Starting Torque Test, Motor Commutation Test, Resolver Operation/ No-Load Speed Test, and Random Vibration. The electronic circuitry was tested at the Circuit Card Assembly (CCA) level of production; each test exercised all circuit functions. The transistor assembly was tested during the W3 cable assembly (1356946-1) test. Refer to Figure 1 for test flow.



Antenna Subsystem and Subsystem Component Test Flow Figure 1.

The antenna drive subsystem satisfactorily passed all of the performance requirements. There were no failures in any of the antenna drive components during subsystem testing.

The results of the subsystem and component level testing are discussed in more detail in the following sections:

Reflector Drive Assembly	5.1
Circuit Card Assemblies	5.2
Signal Processor	5.3
Transistor Assembly	5.4
Antenna Drive Subsystem	5.5

### 3.0 TEST CONFIGURATION

The *Reflector Drive Assembly Tests* confirm the operability of the motor under test. The test configuration includes, the motor, motor shaft, bearings, and a supporting housing.

The *Circuit Card Assembly (CCA) Tests* confirm the operability of each CCA. Each test includes the CCA under test, electronic test fixtures, and the necessary loads.

A segment of the *Signal Processor Tests* ensures the scan drive electronics are functioning properly prior to it's assembly into the instrument. The test configuration includes:

- Timing and Control CCA
- Scan Control Interface CCA
- Relay Driver and Current Monitor CCA
- Interface Converter CCA
- Resolver Data Isolator CCA
- R/D Converter CCA
- Motor Driver CCA
- Test fixture and cabling to simulate the spacecraft bus interface
- Test fixture and cabling to interrogate and analyze positional data
- Test motor and inertia wheel

The *Transistor Assembly Test* verifies the correct wiring of the transistor assembly and associated cabling. Test configuration includes the CKT 1000 (continuity and Hi-Pot tester), and test fixtures.

### The Antenna Drive Subsystem Tests:

- Are configured with the same motor control CCA's used in the signal processor test, interconnecting wiring, the power transistor assembly, and the drive assembly with reflector.
- The antenna drive subsystem components were all installed in the instrument when the subsystem test was performed.
- DC power for the motor control circuit cards was provided by a DC/DC converter simulator P/N: 1359322-1. The simulator operates on 120VAC facility supplied power. The power for the reflector motor drive circuits however was provided directly by the STE 28V Bus power supply.

### 4.0 TEST SETUP

The antenna drive subsystem tests are performed during system integration. During system integration testing, the instrument is proven electrically safe via ground isolation, and power distribution checks. Next, the communication link is exercised to ensure commands are received and interpreted correctly. The Antenna Drive Subsystem Test is then performed.

### 5.0 TEST RESULTS

The Antenna Drive Subsystem components designated for use in the METSAT AMSU-A2 S/N 105 instrument are shown in Table 1. During preliminary testing of these components (in preparation for the antenna drive subsystem test), several component failures occurred. The component failures and system related dispositions are listed below:

- Compensator Drive Motor failed motor current limit at -10°C plateau; both CW and CCW. The specification was modified, with customer approval, to accommodate the out of tolerance condition.
- Transistor Assembly failed continuity tests due to incorrect wiring. The assembly was re-wired and passed all subsequent tests

CCA	S/N
Resolver Data Isolator Assembly	F28
Interface Converter Assembly	F23
Scan Motor Driver Assembly	F09
Compensator Driver Assembly	F06
R/D Converter/ Oscillator Assembly	F09

OTHER	S/N
Reflector Drive Motor	F02
Compensator Drive Motor	F06
Signal Processor	F01
Transistor Assembly (W3 cable)	N/A

TABLE 1
METSAT AMSU-A2 S/N 105 Antenna Subsystem Component S/N Designations

All other components designated for use in the METSAT AMSU-A2 instrument (pertaining to the scan drive circuitry) passed on the first time through component testing.

#### 5.1 ANTENNA AND COMPENSATOR DRIVE ASSEMBLY

The tests performed on these units are: Starting Torque Test, Motor Commutation Test, Resolver Operation/ No-Load Speed Test, and Random Vibration. The Motor Commutation and Resolver Operation tests are performed both pre and post-vibration.

### **Starting Torque**

The starting torque test is performed on the rotating segment of the drive assembly to verify the torque associated with bearing friction. Both the reflector drive assembly (F02) and the compensator drive assembly (F06) passed the starting torque test at ambient temperature as well as at the colder plateaus.

### **Motor Commutation Test**

This test is performed to determine the commutation characteristics of the motor under test. The reflector drive assembly (F02) passed the motor commutation test both pre- and post-vibration tests without incident. The compensator drive assembly (F06) failed the current limit requirement at the -10°C plateau. Relief from the specification requirement was requested for and granted by the customer via FRB.

### Resolver Operation/ No-Load Speed Test

This test is performed to verify resolver operation as well as speed characteristics and back electromotive force of the motor. Both the reflector drive assembly (F02) and the compensator drive assembly (F06) passed the resolver operation/ no-load speed test both pre- and post-vibration tests without incident.

### Random Vibration

Vibration testing was successfully completed; both motors passed the vibration requirements without incident. Both the reflector drive assembly (F02) and the compensator drive assembly (F06) passed the pre- and post-vibration electronic tests as well as the post-vibration visual inspection without incident.

### 5.2 CIRCUIT CARD ASSEMBLIES

Test procedures were prepared for each motor control circuit card; document revision status is controlled by reference in the shop order. The cards were individually tested to the procedures and results were recorded on data sheets found in Appendix A. The following list indexes the CCA Test Data Sheets:

- Appendix A1 ...... Resolver Data Isolator Assembly
- Appendix A2..... Interface Converter Assembly
- Appendix A3..... Motor Driver Assembly
- Appendix A4......R/D Converter/ Oscillator Assembly

All circuit card assemblies passed testing the first time through. The assembly build shop orders contain the part number and accept tag record the of test and select resistors.

#### 5.3 SIGNAL PROCESSOR

For the first time, the entire antenna drive motor electronics is mated together. The test instrumentation commands and interrogates the electronics during this segment of testing. The instrumentation sends position commands to the Interface Converter CCA. The Interface Converter D/A's the command and provides inputs to the Motor Driver CCA. The test motor (instrumentation) responds to the drive signal and feeds back positional data via resolver outputs. The instrumentation then interrogates the Resolver Data Isolator CCA for position data. A comparison is made in the instrumentation between the position command sent and the actual position received. The pass/ fail indication is presented to the operator for test data sheet recording.

The signal processor assembly (F01) passed all scan drive tests.

### 5.4 TRANSISTOR ASSEMBLY

All transistor assemblies are tested along with their respective W3 cable. The cable is continuity, then hi-pot tested prior to attaching the transistor circuitry. Each transistor pair is exercised validating the turn on voltage, current drawn, and cable wiring as well.

During continuity testing, prior to applying power to the transistor assembly, it was noted that the transistors were wired improperly. The assembly was rewired in accordance with the corrected planning. Tests results were positive; all components operated as designed.

#### 5.5 ANTENNA SUBSYSTEM DRIVE TESTS

The antenna drive motor electronics mates with the instrument microprocessor for the first time during this segment of testing. The microprocessor sends position commands from the memory CCA to the Interface Converter CCA. The Interface Converter D/A's the command and provides inputs to the Motor Driver CCA. The Reflector Drive Motor responds to the drive signals and feeds back positional data via the resolver outputs. The microprocessor then interrogates the Resolver Data Isolator CCA for position data.. The microprocessor in turn communicates with the spacecraft interface.

During other segments of the test, positional data is monitored via a potentiometer attached to the shaft of the reflector drive assembly. This provides scan characteristic information in regard to overshoot, jitter, and beam position transition timing.

The remaining paragraphs in this section discuss tests that ensures the instrument complies with specific operating parameters. Prior to conducting these tests there is a series of preliminary checks that are run to select component values that customize the operating parameters of the instrument. These checks perform the following functions:

- Program "on board" memory with Beam Position Pointing Angles
- Adjust for peak Motor Current Limits
- Observe Preliminary Scan Dynamics
- Identify Mechanical Resonant Frequencies

**Beam Position Pointing Angles** are calculated from Nadir pointing direction which is determined on the antenna range. The instrument's EPROMs (EPROMs for testing; PROMs for final configuration) are programmed to reflect the position commands. The initial programming may require fine tuning; fine tuning is determined during the remaining segments of the test procedure.

*Motor Current Limits* were adjusted, via selecting "test and select" resistors, to comply with the specification requirement; less than 2 amp peak current.

**Preliminary Scan Dynamics** looked good; transition times, overshoot and jitter were all acceptable at the sampled pointing directions (5).

The *Mechanical Resonant Frequencies* were identified; notch filters were calculated and installed to compensate for these resonant frequencies.

### 5.5.1 SCAN MOTION AND JITTER

In this test, the antenna position was measured in a series of five 8-sec full scans. The measurement was made with a 1-turn test potentiometer temporarily affixed to the rear end of the motor shaft. A Dynamic Signal Analyzer (DSA) was connected to the pot wiper to record the antenna position data. Five scans were captured and stored on the AMSU-A2 Test Data File disc. One representative waveform is presented in Appendix B1.

Each 3.33 degrees scene step was expanded and checked for a 42 msec max step time, and the 158 msec integration period. Expanded waveforms were plotted and are presented in Appendix B2 thru B30. All of the scene steps meet the step response requirement for transition time, overshoot, and jitter.

Slew periods to the cold and warm calibration stations were measured and met requirements. A time of 0.21 sec is allocated for the 35.0 degree slew to cold cal, and 0.40 sec for the 96.67 degree slew to warm cal. Calibration station jitter was less than the  $\pm$  5 % maximum permitted. Expanded waveforms were plotted and are presented in Appendix B31 thru B34. The waveforms are also stored on the AMSU-A2 Test Data File disc. The test data sheet is presented in Appendix B35

#### 5.5.2 NOISY BUS PEAK CURRENT AND RISE TIME

The noisy pulse load bus peak current and the rate of change of current were measured. The peak current must be less than 2A at any beam position along the scan. Peak current along the scan is 1.88A. The current rate of change while transitioning from one beam position to the next (including the transition to the cold calibration and warm calibration targets) should be greater than 70 microseconds. A random 3.33° step was selected; the transition to the next step was 1.1 ms. The transition to the warm cal position start and stop was significantly longer than the required 70 ms; 1.6 and 56 ms respectively.

The peak bus current was measured across the entire scan and met the requirement. The full scan waveform was plotted and is presented in Appendix C1. The waveform is also stored on the AMSU-A2 Test Data File disc. The test data sheet is presented in Appendix C2

#### 5.5.3 RESOLVER READING AND POSITION ERROR

The 14-bit command position word is stored in the "on-board" memory and is read to the motor drive circuitry under microprocessor program control. The microprocessor also

reads the resolver output at each of the thirty scene stations, and at the cold and warm calibration positions. The readings are made at the start of integration (LOOK 1), and halfway into the integration period (LOOK 2). The resolver data is sent to the spacecraft interface for subsequent transmission to the STE.

The purpose of this portion of the test is to demonstrate that the antenna is meeting beam pointing requirements.

If the antenna is out of the pointing tolerance of  $> \pm 10$  counts at LOOK 1 or  $> \pm 5$  counts at LOOK 2, the EPROM is reprogrammed to bring the pointing direction to within the prescribe tolerances. A copy of the STE computer print out showing the pointing direction is shown in Figure 2.

		Act	tual	Differ	ence*
BP	Command	Look 1	Look2	Look 1	Look2
1	6657	6655	6655	2	2
2	6505	6507	6503	-2	2
3	6353	6355	6350	-2	3
4	6202	6204	6199	-2	3
5	6050	6052	6049	-2	1
6	5898	5900	5897	-2	1
7	5747	5748	5746	-1	1
8	5595	5597	5593	-2	2
9	5443	5444	5440	-1	3
10	5292	5293	5288	-1	4
11	5140	5141	5138	-1	2
12	4988	4990	4987	-2	1
13	4837	4839	4834	-2	3
14	4685	4687	4684	-2	1
15	4533	4536	4532	-3	1
16	4382	4384	4381	-2	1

		Actual		Differ	ence*
вР	Command	Look 1	Look2	Look 1	Look2
17	4230	4232	4227	-2	3
18	4078	4080	4076	-2	2
19	3927	3928	3923	-1	4
20	3775	3777	3774	-2	1
21	3623	3627	3621	-4	2
22	3472	3475	3470	-3	2
23	3320	3323	3319	-3	1
24	3168	3171	3167	-3	1
25	3017	3020	3015	-3	2
26	2865	2868	2862	-3	3
27	2713	2716	2710	-3	3
28	2562	2564	2558	-2	4
29	2410	2412	2408	-2	2
30	2258	2260	2255	-2	3
CC 1	665	665	666	0	-1
WC	12650	12650	12651	0	-1

Figure 2. Beam Position Pointing Directions and Error Calculation

#### 5.5.4 GAIN/PHASE MARGIN

A gain/phase margin test was performed on the antenna drive subsystem. The test was performed by obtaining a Bode plot of the control loop and measuring the gain at 180° phase differential and the phase margin at the 0db crossover point.

The Dynamic Signal Analyzer (DSA) was used to make the measurement operating in the swept sine mode. Three separate Bode plots were made on the antenna and the gain and phase margins were determined from each plot. The gain margin measured was 13.5 db (average of three) and the phase margin measured was 60.7 degrees (average of three). These margins exceed the specification requirements of 12 db and 25 degrees and therefore are acceptable. The three Bode waveforms were plotted and are presented in Appendix D1 thru D3. The waveforms are also stored on the AMSU-A2 Test Data File disc. The test data sheet is presented in Appendix D4.

#### 5.5.5 OPERATIONAL GAIN MARGIN

An operational gain margin test was performed on the instrument three times. This test consists of increasing the gain of the control loop until oscillation occurs. The gain increase and frequency of oscillation are measured. An increase in gain greater than 9 db is required; the frequency of oscillation is an observation.

A 50K pot was connected in series with the R58 feedback resistor on amplifier AR8. The resistance of the test pot was slowly added to the feedback resistor while observing the reflector for oscillations.

The reflector begins to produce an audible sound as gain is increased. The following added resistance values are calculated to have the following gain margins:

Resistance	Gain
38.58	9.3 db
41.20	9.7 db
42.88	9.9 db

The first mode mechanical resonance of the shaft and reflector is about 228 Hz as shown in the power spectrum. The power spectrum waveform was plotted and is presented in Appendix E1. The waveform is also stored on the AMSU-A2 Test Data File disc. The test data sheet is presented in Appendix E2.

### 6.0 CONCLUSION

Based on the test results, it can be concluded that the METSAT AMSU-A2 S/N 105 antenna drive subsystem meets the AMSU-A specification requirements.

#### 7.0 TEST DATA

Test data for the AMSU-A2 S/N 105 obtained in the antenna drive subsystem test is attached. Data sheet number and type of test is shown in the following Appendix Index.

## APPENDIX INDEX

Appendix A1Resolver Data Isolator CCA TDS
Appendix A2 Interface Converter CCA TDS
Appendix A3 Motor Driver CCA TDS
Appendix A4R/D Converter/ Oscillator CCA TDS
Appendix B1Full Scan Step Response
Appendix B2 thru B30Single Step Responses
Appendix B31 and B32Cold Calibration Step Response
Appendix B33 and B34Warm Calibration Step Response
Appendix B35Scan Motion Jitter Test TDS
Appendix C1Peak Pulse Load Bus Current Waveform
Appendix C2Pulse Load Bus Current TDS
Appendix D1 thru D3Gain/ Phase Margin Bode Plots
Appendix D4Gain/ Phase Margin TDS
Appendix E1Operational Gain Margin Power Spectrum
Appendix E2Operational Gain Margin TDS

## TEST DATA SHEET B-6 (Sheet 1 of 2)

### RESOLVER DATA ISOLATOR CCA (P/N 1334972) (Paragraph 6.6.7)

Date: S/N:

4/14/97

F-28

1334972-1

### 6.6.7.1 Supply Voltages

Supply*	Measured Value (V)	Limits (Vdc)	Pass/Fail
+5 V (I)	5,00	± 0.25	
+5 V (Ŭ)	5.01	± 0.25	8

### 6.6.7.2 Supply Currents

Steps 1 and 2:

	Supply*	Measured Value (mA)	Limits (mA)	Pass/Fail
+5 V	(I)	53,27	100 max	P
+5 V	(U)	320.41	400 max	P

Steps 3 and 4:

Supply*	Measured Value (mA)	Limits (mA)	Pass/Fail
+5 V (I)	83.24	150 max	P
+5 V (U)	11.06	30 max	P

<sup>\*</sup> I = Isolated, U = Unisolated

### 6.6.7.3 Resolver Data

Bit No.	Pass/Fail
API 0 - AP Bit 0	P
API 1 - AP Bit 1	ſ
API 2 - AP Bit 2	1
API 3 - AP Bit 3	P
API 4 - AP Bit 4	P
API 5 - AP Bit 5	
API 6 - AP Bit 6	f
API 7 - AP Bit 7	P
API 8 - AP Bit 8	P
API 9 - AP Bit 9	P
API 10 - AP Bit 10	P
API 11 - AP Bit 11	P
API 12 - AP Bit 12	ę
API 13 - AP Bit 13	ρ

### 6.6.7.4 Converter Busy Pulse

Converter Busy Pulse	Measured Value (μsec)	Limits (µsec)	Pass/Fail
15.0	14,9	± 3.0	Р

And States to the States of th

## TEST DATA SHEET B-6 (Sheet 2 of 2)

# RESOLVER DATA ISOLATOR CCA (P/N 1334972) (Paragraph 6.6.7)

Comments:	
	N 5 D
Conducted by:	Rest Engineer Date  Date  14/14/17  Date
Verified by:	Quality Control Inspector  Date  14-14-97  Outlity Control Inspector  Date
Approved by:	DCMC Date

## TEST DATA SHEET B-13 (Sheet 1 of 3)

# INTERFACE/CONVERTER CCA (P/N 1331697) (Paragraph 6.13.7)

Date:

5/1/91

CCA S/N:

F23 133 | 697-1

## 6.13.7.1 Supply Voltages

Commiss	Measured Value (Vdc)	Limits (Vdc)	Pass/Fail
Supply +5V (U)	+5, 01Y	+5V± 0.05	P
+3V (U)	-115.03V	+15V± 0.15	f
-15V (I)	-15.01V	-15V± 0.15	P
+5V (I)	15.06 V	+5V± 0.05	P

## 6.13.7.2 Supply Currents

## Step 1 (CP and API Low):

Consider	Measured Value (mA)	Limits (mA)	Pass/Fail
Supply +5V (U)	85.96 hA	70 - 110	P
+5V (I)	3.42 MA	1.5 - 5.5	β
+15V (I)	18.05ma	15 - 23	
-15V (I)	20.34 mA	18 - 26	<u> </u>

## Step 2 (CP and API High):

		Limits (mA)	Pass/Fail
Supply	Measured Value (mA)		1 433/1 411
+5V (U)	56.24 MA	40 - 70	
	23.84 mA	18 - 30	P
+5V (I)	18.05 mA	15 - 23	- P
+15V (I)	20.84 mA	18 - 26	P
-15V (I)	20.39 Mg	10-20	

## 6.13.7.3 Amplifier Offsets

Amplifier	Measured Value (mV)	Limits (mV)	Pass/Fail
Amplifier AR1	- 0. 01 mV	0.0 ±0.15	P
AR2	-0.26mV	0.0 ±2.0	P
A KZ	TO DO THE		

## TEST DATA SHEET B-13 (Sheet 2 of 3)

## INTERFACE/CONVERTER CCA (P/N 1331697) (Paragraph 6.13.7)

## 6.13.7.4 Subtraction and D-A Conversion

## Step 1:

Actual Position (API)	Command Position (CP)	AR1 Output*	Test Result	<del></del>
MSB LSB	MSB LSB	Voltage Required (Vdc)	(Vdc)	Pass/Fail
0000000000000	0000000000000	0.00000	-0.00001	P
000000000001	00000000000000	-0.00061	-0.00067	P
0000000000010	0000000000000	-0.00122	-0.00134	P
000000000011	0000000000000	-0.00184	-0.00197	P
000000000100	00000000000000	-0.00245	-0.00261	P
0000000001000	0000000000000	-0.00490	-0.00515	P
0000000010000	0000000000000	-0.00979	-0.01025	P
0000000100000	0000000000000	-0.01958	-0.02044	P
0000001000000	0000000000000	-0.03917	-0.04083	ρ
00000010000000	0000000000000	-0.07834	-0.08162	P
00000100000000	0000000000000	-0.15667	-0.16320	P
0000100000000	0000000000000	-0.31334	-0.32 639	P
0001000000000	0000000000000	-0.62669	-0.65285	P
0010000000000	0000000000000	-1.25338	-1.3059	P
01000000000000	0000000000000	-2.50675	-2.6117	P
1000000000000	00000000000000	-5.01350	- 5.2235	P

<sup>\*</sup> Tolerance on output voltage is ± 10%

Step 2:

Actual Position (API)	Command Posi	tion (CP)	AR1 Output*	Test Result	· · · · · · · · · · · · · · · · · · ·
MSB LSB	MSB	LSB	Voltage Required (Vdc)	(Vdc)	Pass/Fail
0000000000000	0000000000	0000	0.00000	-0.00002	Р
0000000000000	0000000000	0001	0.00061	40.00055	P
0000000000000	0000000000	0010	0.00122	10.00117	P
00000000000000	0000000000	0011	0.00184	10.00174	P
00000000000000	0000000000	0100	0.00245	10.00245	P
0000000000000	000000000	1000	0.00490	10.00501	P
0000000000000	000000001	0000	0.00979	10.01014	P
0000000000000	000000010	0000	0.01958	10.020345	P
0000000000000	000000100	0000	0.03917	10.04074	P
0000000000000	00010000	0000	0.07834	+0.08154	ř
0000000000000	000010000	0000	0.15667	+0.16321	P
0000000000000	0000100000	0000	0.31334	10.32645	P
0000000000000	0001000000	0000	0.62669	+0-65306	P
0000000000000	0010000000	0000	1.25338	+1.3057	P
0000000000000	0100000000	0000	2.50675	+2.6114	P
00000000000000	1000000000	0000	-5.01350	-5. 2235	Ρ

<sup>\*</sup> Tolerance on output voltage is  $\pm 10\%$ 

## Fills

## TEST DATA SHEET B-13 (Sheet 3 of 3)

# INTERFACE/CONVERTER CCA (P/N 1331697) (Paragraph 6.13.7)

6.13.7.5 Strobe Function	
Step 1: Strobe Low	Pass/Fail
No E11 Change with Input CP Changes	<b>-</b>
Step 2: Strobe High	<u>Pass/Fail</u>
E11 Change with Input CP Changes	
6.13.7.6 Amplifier Gain	
Measured Value (Vdc) E11 0.32645	Limits (Vdc) Pass/Fail - P
E10 3.5913	- <u>P</u>
E10 Voltage II.U E11 Voltage	10.7 - 11.3 <u>P</u>
6.13.7.7 Ground Isolation	
Measured Value (MΩ Pin 91 to Pin 7 DC Resistance  200 μ	) Limits (M $\Omega$ ) Pass/Fail >20
Comments:	
Conducted by:  Test Engineer	$\frac{5/1/47}{\text{Date}}$
Verified by: Quality Control Inspector	$\frac{\cancel{5}}{\cancel{5}} \frac{5/8/97}{\cancel{Date}}$
Approved by:	Date Date

## TEST DATA SHEET B-4 (Sheet 1 of 2)

## MOTOR DRIVER 3-HALL SENSOR CCA (P/N 1331694) (Paragraph 6.4.3)

S/N:

FØ6 4/4/91

Date:

1331694 -4 6.4.3.2 <u>Input Signal Offset</u>

Step No.	Test Results	Limits
4	1.78mV	0.0 ±1 mVdc
6	1.46 mV	0.0 ±1 mVdc
8	1.60 mV	0.0 ±1 mVdc

Step No.	Test Resistor	Resistance Measured
13	E7-ES (R25)	3,4K
	E9-E10 (R52)	6.76K
	E11-E12 (R33)	3.16K
	E13-E14 (R53)	5,2°k
	E15-E16 (R42)	3.16K
	E17-E18 (R54)	3.61k

Step No.	Resistors	Selected Trim Resistors
14	R25	RNC555 3401FS
-	R52	RNC555 6311 FS
	R33	RNC55J3161FS
	R53	RNC55J5231FS
	R42	RNC55J3161FS
	R54	RNCSSJS6ZIFS

Step No.	E Point	Test Results	Limits	¿ Pass/Fail
19	E19	-0.07mV		P
·	E20	-0-11 mV	0.0 ±1 mVdc	P
ŀ	E21	-0.12 mV	0.0 ±1 mVdc	P

## 6.4.3.3 Motor Driver Operation

### Clockwise Rotation:

Step No.	Test Results	Limits	Pass/Fail
2	4.99V	+5V±0.05Vdc	P
_	58.6 mA	70mAdc max	ρ
	15.07V	+15V±0.15Vdc	ρ
	1.5 m A	3.0m.Adc max	P
ı	-14.98V	-15V±0.15Vdc	P
	18-8 mA	25mAdc max	P
	28.01V	+28V±0.5Vdc	P
	5.6mA	8mAdc max	P
3	344nV	400mVdc max	P
4	44.5 mg	50mAdc max	P
5	47.2 mA	50mAdc max	P

## TEST DATA SHEET B-4 (Sheet 2 of 2)

## MOTOR DRIVER 3-HALL SENSOR CCA (P/N 1331694) (Paragraph 6.4.3)

## Counter Clockwise Rotation:

Step No.	Test Results	Limits	Pass/Fail
3	282 mV	400mVdc max	P
4	36.6 MA	50mAdc max	P
. 5	39.9 mA	50mAdc max	P

## 6.4.3.4 Current Limit Test

Comments: NONE

Step No.	Test Results	Limits	Pass/Fail
2	439 MA	350-500mAdc	P

Conducted by:	Denensalus 4/21/91
Verified by:	Test Engineer Date Date 04/28/97
· united by:	Ourthu Control Tournator

Approved by:

Qate Qate

### TEST DATA SHEET B-4 (Sheet 1 of 2)

## MOTOR DRIVER 3-HALL SENSOR CCA (P/N 1331694) (Paragraph 6.4.3)

S/N:

FØ9

Date:

4/21/97

1331694-4 6.4.3.2 <u>Input Signal Offset</u>

Step No.	Test Results	Limits
4	1.53 mV	0.0 ±1 mVdc
6	1.11 WV	0.0 ±1 mVdc
8	1.21 hV	0.0 ±1 mVdc

Step No.	Test Resistor	Resistance Measured
13	E7-ES (R25)	3.40K
	E9-E10 (R52)	5.97k
	E11-E12 (R33)	3.16k
	E13-E14 (R53)	4.55K
	E15-E16 (R42)	3.40K
	E17-E18 (R54)	5.23K

Step No.	Resistors	Selected Trim Resistors
14	R25	RNC55534ØIFS
	R52	RNC5516041 FS
	R33	RNC5553161F5
· [	R53	RN(5554531FS
	R42	RNC55J34ØIFS
	R54	RNC55J5231FS

Step No.	E Point	Test Results	Limits	Pass/Fail
19	E19	0.02 MV	0.0 ±1 mVdc	P
	E20	0-08mV	0.0 ±1 mVdc	P
	E21	0.10hV	0.0 ±1 mVdc	P

### 6.4.3.3 Motor Driver Operation

### Clockwise Rotation:

Step No.	Test Results	Limits	Pass/Fail
2	Test Results 5.00 V 51.9 mA 15.07 V 1.5 mA -14.98 V 18.6 mA 28.03 V 5.6 mA 279 m V	+5V±0.05Vdc	P
	56.9ma	70mAdc max	P
		+15V±0.15Vdc	P
	1.5mA	3.0mAdc max	P
	-14.98V	-15V±0.15Vdc	P
		25mAdc max	P
-	28.03V	+28V±0.5Vdc	P
		8mAde max	P
3		400mVdc max	P
4	42-6 mA	50mAdc max	P
-5	47.9ma	50mAdc max	P

## TEST DATA SHEET B-4 (Sheet 2 of 2)

# MOTOR DRIVER 3-HALL SENSOR CCA (P/N 1331694) (Paragraph 6.4.3)

### Counter Clockwise Rotation:

Step No.	Test Results	Limits	Pass/Fail
3	2-11 mV	400mVdc max	P
4	36.4 BA	50mAdc max	P
-5	19.7 BA	50mAdc max	P

## 6.4.3.4 Current Limit Test

Step No.	Test Results	Limits	Pass/Fail
2	440MA	350-500mAdc	[f

Comments:	NONE	

Conducted by:

Verified by:

Test Engineer

4/21/97

Date

a line Consol Innoces

04/28/9

Date

Approved by:

4/29/99

### TEST DATA SHEET B-5 (Sheet 1 of 3)

## R-D CONVERTER/OSCILLATOR CCA (P/N 1337739) (Paragraph 6.5.7)

Date 8	126/97
CCA S/N_	F09
	1337739-2
6.5.7.1	<b>UUT Pre-Test</b>

Step 2:

Supply Currents (Without UUT)

Supply (Vdc)	(Baseline) Measured Value (mA) (Without UUT)	Limits (mA)	Pass/Fail
+15	0.06	0-1	P
-15	-0.29	-1 - 0	P
+5	0.06	0-1	P

## Supply Voltages (Without UUT)

Supply	Measured Value (V)	Limits (V)	Pass/Fail
+15V (I)	15.02	± 0.50	β
-15V (I)	-15.01	± 0.50	P
+5V (I)	5.03	±0.25	P

Step 6:

### Supply Currents (UUT Installed)

Supply (Vdc)	Measured Value (mA) (UUT Installed)	Difference (mA) (Measured - Baseline)	Limits (mA)	Pass/Fail
+15	32.82	32.76	20-40	1 8
-15	~41.07	- 40.78	-3050	Ρ
+5	55.65	54.99	30-70	<u> </u>

### 6.5.7.2 Supply Voltages (UUT Installed)

Supply	Measured Value (V)	Limits (V)	Pass/Fail
+15V (I)	15.01	± 0.50	P
-15V (I)	-14.96	± 0.50	P
+5V (I)	5.02	±0.25	P

## 6.5.7.3 Oscillator Frequency, Duty Cycle, and Output Voltage

Parameter	Measured Value	Limits	Pass/Fail
Frequency	160 OHZ	1550-1650 Hz	P
Duty Cycle	51%	45-55 %	'P
Output Voltage	8.19V	7.6-8.4 Vrms	P

### TEST DATA SHEET B-5 (Sheet 2 of 3)

## R-D CONVERTER/OSCILLATOR CCA (P/N 1337739) (Paragraph 6.5.7)

### 6.5.7.4 R-D Converter Operation

### Step 1:

		CON
Bit Number/	CW	CCW
Test Fixture Label	Pass/Fail	Pass/Fail
API 0/1	P	f
API 1/2	<u>P</u>	l l
API 2/3	<u> </u>	ļ ģ
API 3/4	P	ľ.
API 4/5	β	
API 5/6	β	<u> </u>
API 6/7	β	P P
API 7/8	<u> </u>	
API 8/9	f	P
API 9/10	۴	l P
API 10/11	β	ļ P
API 11/12	P	P
API 12/13	ρ	ļ
API 13/14	β	P
Converter Busy	ρ	<u> </u>

Step 2:

RS (F10)	Measured Value (Vdc)	Calculated Value (Vdc) * CCA -1 Assy	Calculated Value (Vdc) * CCA -2 Assy	Pass/Fail
(E10) CW Rotation**	1. 472	(+) N/A	(+) 1.790	l f
CCW Rotation**	-1.635	(-) N/A	(-) 1.79c	

\* Signal level function of test and calibration gain resistors. Record calculated value and measured value. Measured value shall be within ±10 percent of calculated value. The equation is as follows:

$$V = \pm 0.155 \left(\frac{R20}{R17}\right) \pm 10\%$$

$$\frac{20}{3-26-97}$$

$$V = \pm 0.155 \left(\frac{R20}{R17}\right) \pm 10\%$$

$$\frac{20}{20} = 0.155 \left(\frac{59 \text{ K}}{5.11 \text{ K}}\right)$$

8-25-91

### 6.5.7.5 Amplifier Gain

Measured Value (Vdc)	Limits (Vdc)	Pass/Fail
1.162 V	1.00 to1.30	P
1.086V	1.00 to 1.30	<u> </u>
	(Vdc) 1.162 V	(Vdc) 1. 162 V 1.00 to 1.30

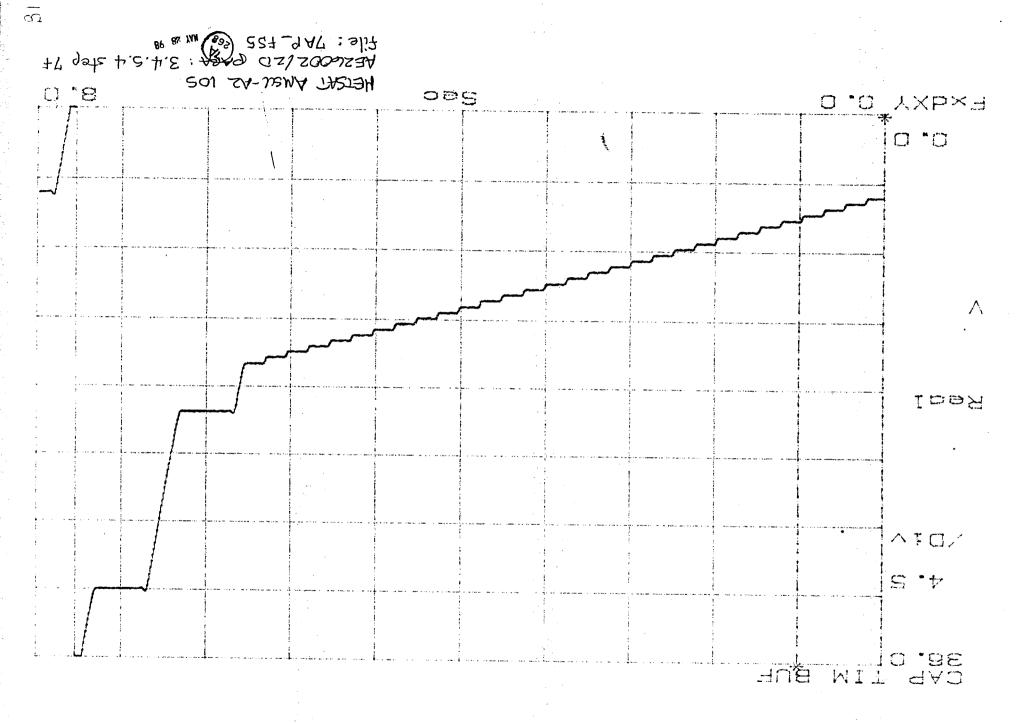
### 6.5.7.6 Direction Control Signal

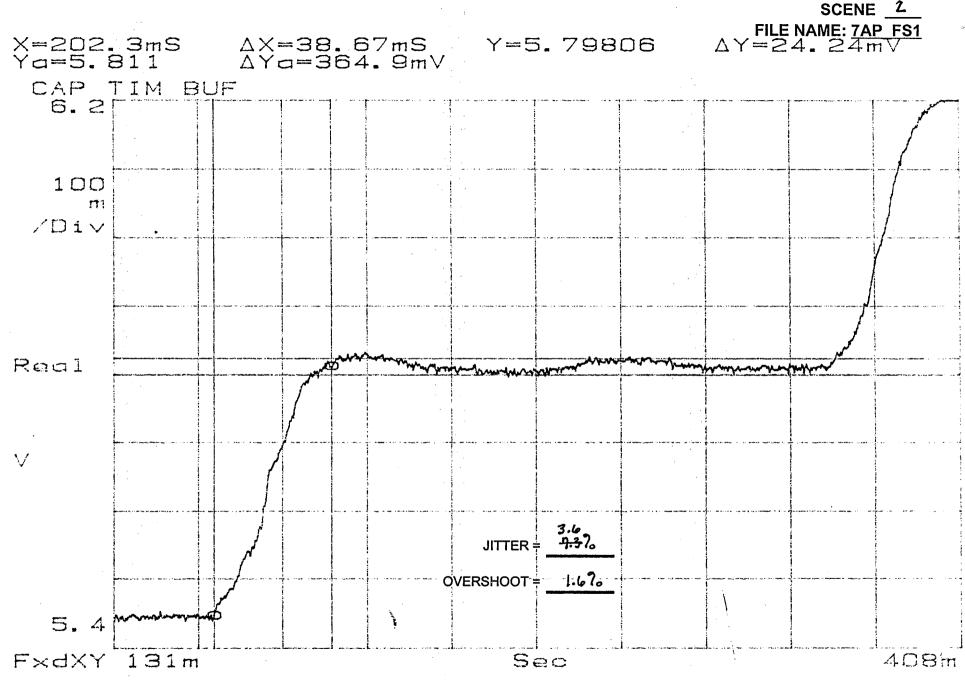
DIR CNTRL	Measured Value (Vdc)	Limits (Vdc)	Pass/Fail
CW Rotation	5.00V	4.5 to 5.5	P
CCW Rotation	0.121V	0.0 to 0.4	P

## TEST DATA SHEET B-5 (Sheet 3 of 3)

# R-D CONVERTER/OSCILLATOR CCA (P/N 1337739) (Paragraph 6.5.7)

Frequency	Measured Value (Hz)	Calculated Value (Hz) * CCA -1 Assy	Calculated Value (Hz) * CCA -2 Assy	Pass/Fa
AR3 Notch	N/A	N/A	N/A	N/A
AR4 Notch			<del>                                     </del>	+ +
AR5 Notch	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	fuelnes determined haven	and calibration resistors. Rec	ord calcul
and measured values.  Comments:				
•				
·				
		,		
		·:		
	•			
Conducted by:	Test Engineer 7A	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	<u>1</u> -	
Verified by:	Quality Control Inspector	Nov 19 '07 Date	-	_
Approved by:	DCMC		_	•

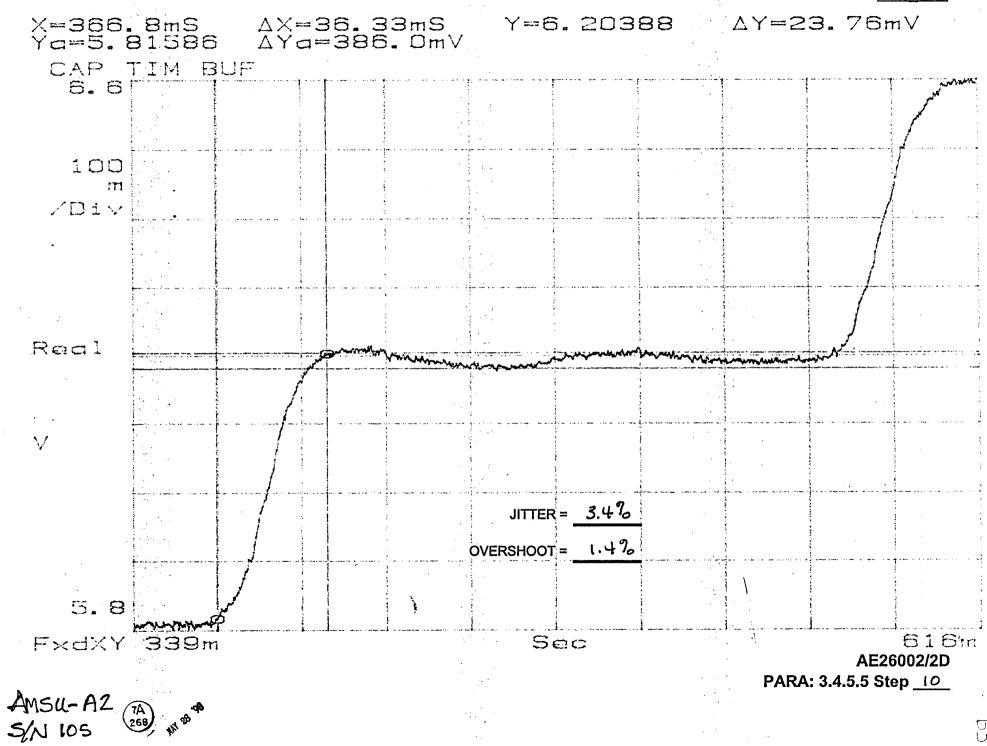




AE26002/2D PARA: 3.4.5.5 Step <u>9</u>

AMSU-AZ (7A) 1105 SIN 105

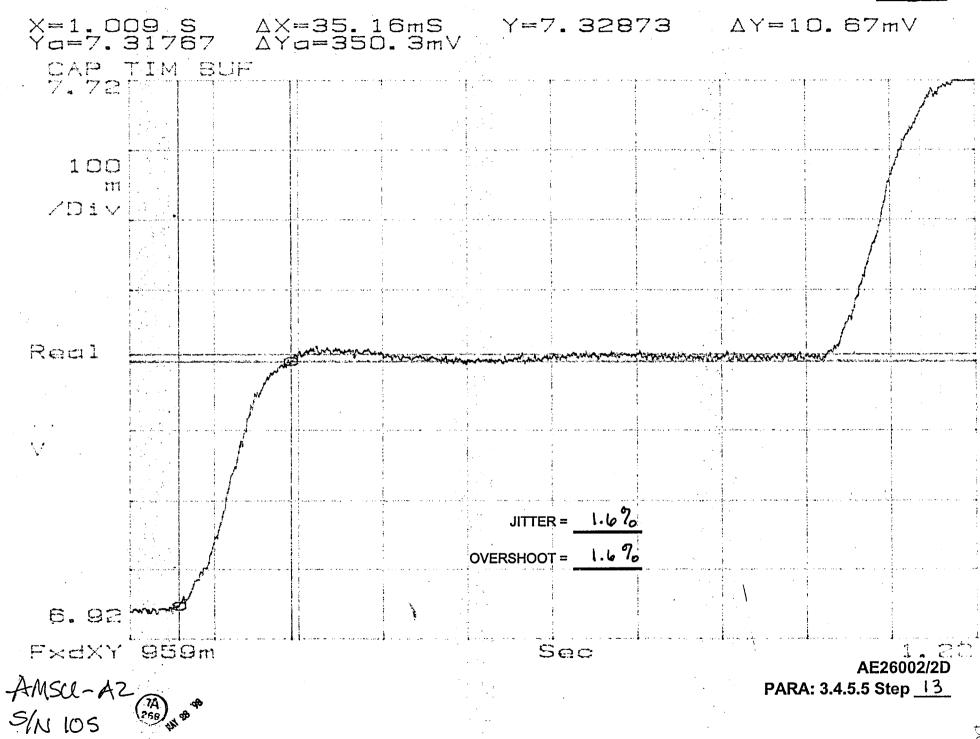
SCEN 2 FILE NAME: 7AP FS1



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64 \*\* SOI N/S PARA: 3.4.5.5 Step \_\_\_\_ **VES000S/SD** HYAZY YXBXF Sec H108 Sr.I = TOOHSAEVO -84.ε = 3.4% Real IMICA 001 86 \*9 CAP TIM BUF VH=22. 79mV FILE NAME: 7AP FS1 SCEV 4

SCEN 6 FILE NAME: 7AP FS1

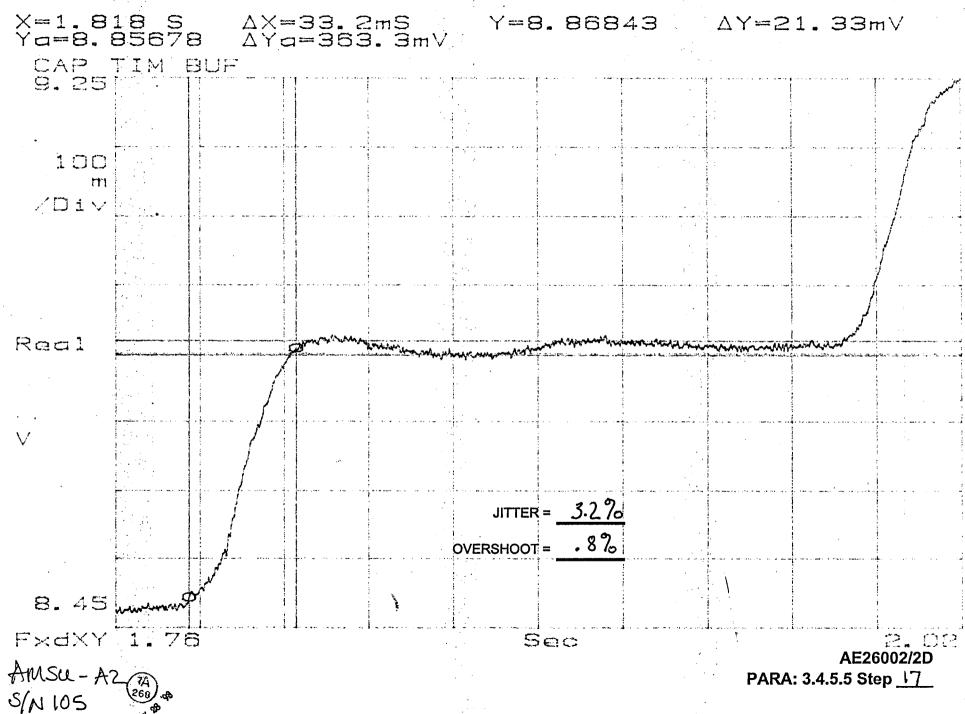


501 M/S AT SA-USMA 과 q912 3.4.5.5 Step 나 **VES6002/2D** 085 EXGX人 IT I B ZE "Z OVERSHOOT = 7.8 % 61.8 = A∃TTIL HOOL AFOZ 100 LIM BOL FILE NAME: 7AP FS1

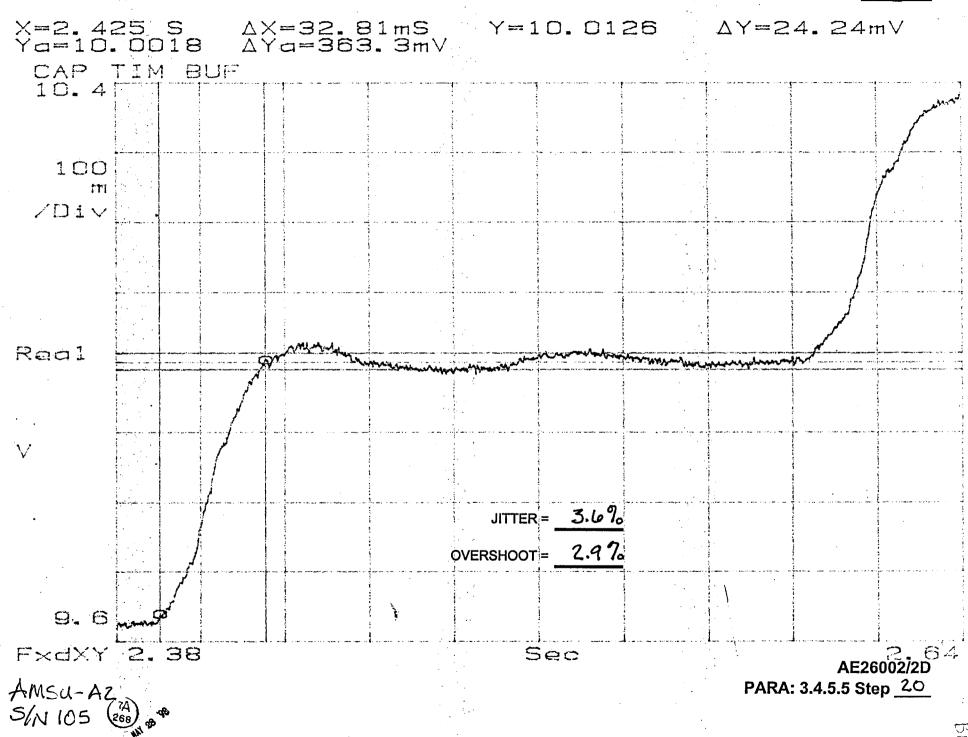
ZCEI/

88 \* SA-NSMA 201 N/S 21 q918 3.4.5.5 Step **VE**26002/2D EXAXY 1, 36 085 59 1/2 OVERSHOOT = Real NEUZ 001 72860 8=4 SH40 SE=AA 71680 8=bY 72860 8=bY 2860 8=b **△₩8** "22=↓▽ FILE NAME: 7AP FS1 ンコつの

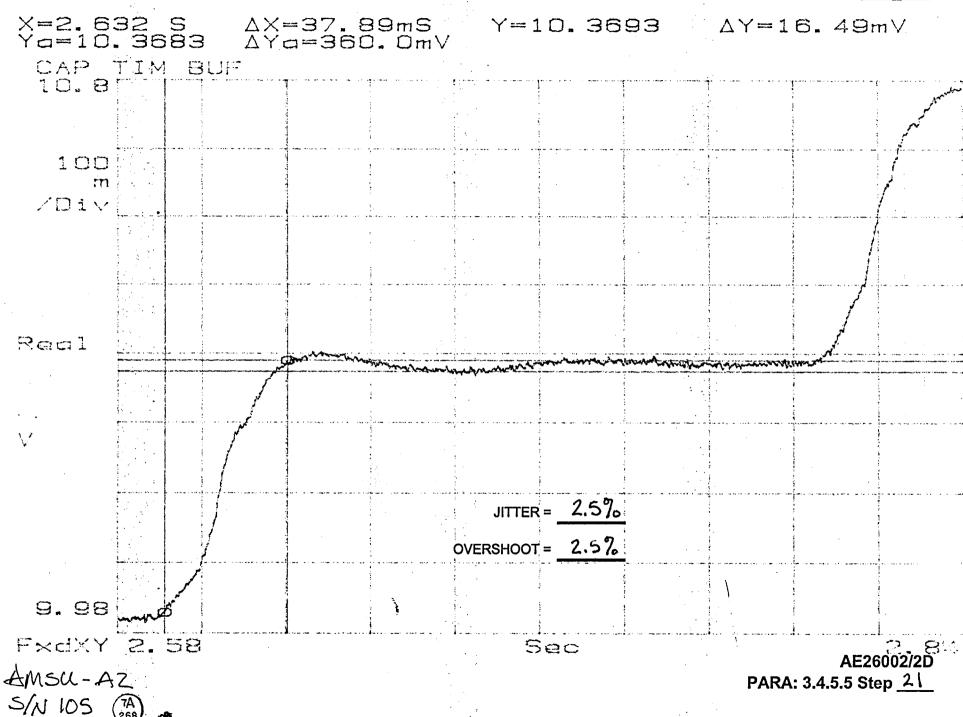
SCEN 10 FILE NAME: 7AP FS1



Bi 501 N/S zy-nsniy PARA: 3.4.5.5 Step 19 AE2600272D F×4XY 2, 17 085 6.23 = TOOHSA3VO % P.S = A3TTIL Real ヘチロノ Ш OOI HU8 MIT Y=2, 62877 △Yd=353, 6mV X=2, 225 S △X=33, 59mS \m68 \*61=\V ESSS9 \*6=\ FILE NAME: 7AP FS1



SCEN 1+ FILE NAME: 7AP FS1

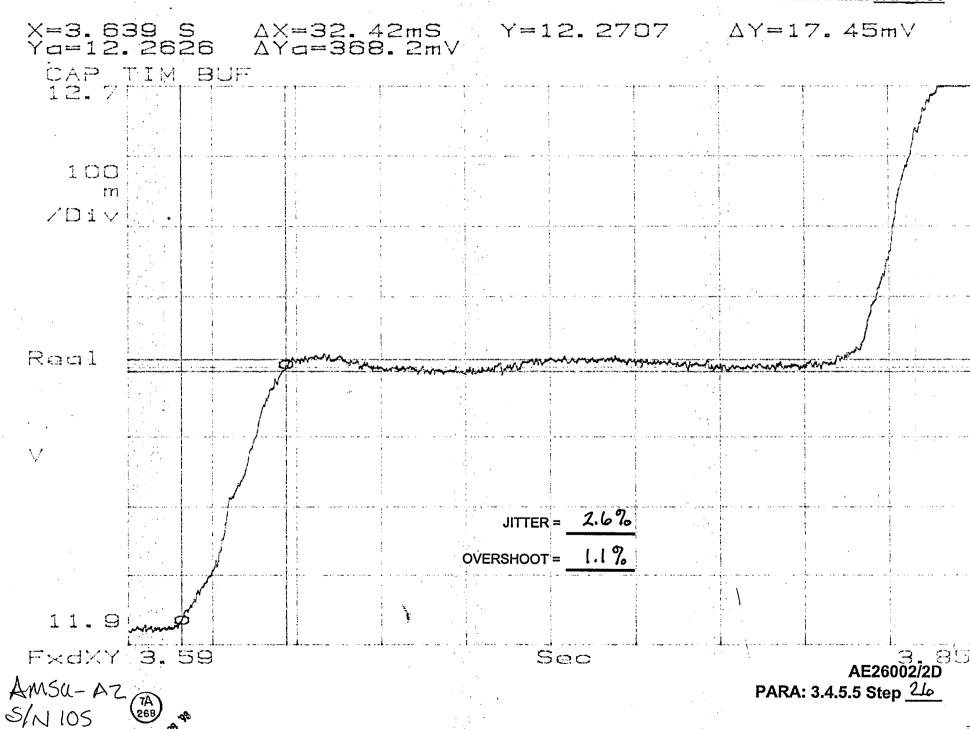


<u>B</u> 24-75WX 22\_ qets 5.6.5.5 Step AE26002/2D EX9X人 5" 18 260 OVERSHOOT = 85.5 = ABTTIL Real AFO/ 144 DOI BUE X=2,831 S Yd=10,7478 V#8 .263.244 V#8 .636=bY∆ 人=10" 7662 FILE NAME: 7AP FS1 CT VANS

ZA-DSWA ES q918 3.4.5.5 Step ES **VE**26002/2D EX9XX 5\* 88 008 3 5 OVERSHOOT = 2.3% %4.8 = A∃TTIL Recl ヘチロノ OOI BILL 1891 11=PX S ZEO E=X \"!"76E=P人♡ S"S"ZE=XV V=11, 1668 A Y=22, 79mV FILE NAME: 7AP FS1 ノニコンウ

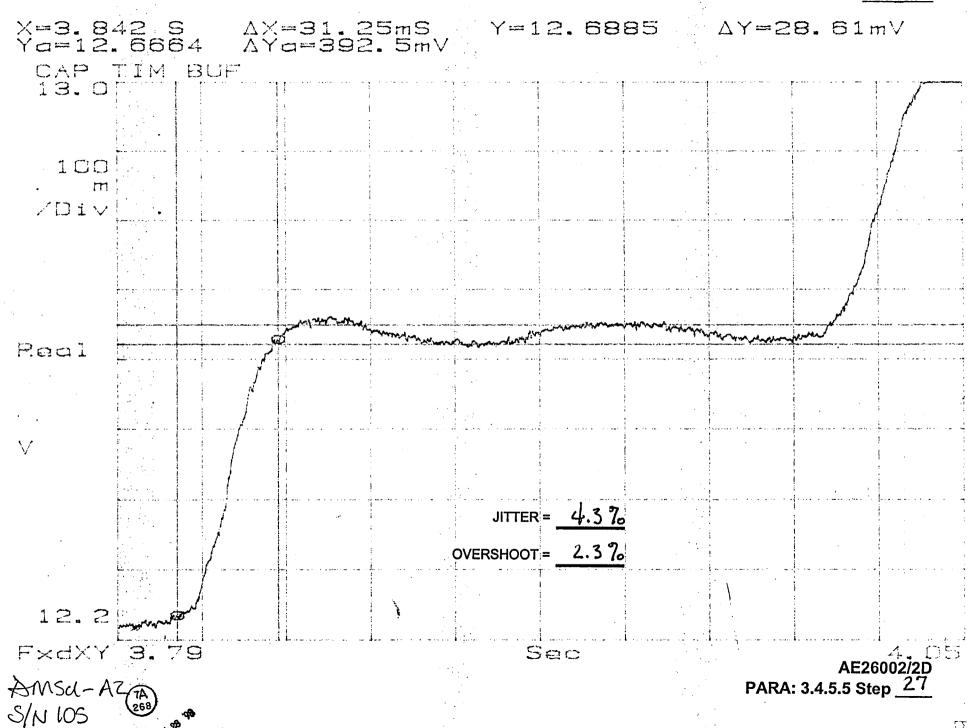
Bir 501 ... S01 ... AE26002/2D 나스 qef 3.4.5.5 Step 소나 EMAXY 3, 19 085 OVERSHOOT = 2.0 % % €. E = A∃TTIL Real NEUZ BUF Y=3, 236 S ∆Y=33, 2mS X=33, 2mS 6425 °II=A **▽▼ 1.2= 7.** FILE NAME: 7AP FS1 VIII 20

PARA: 3.4.5.5 Step 25

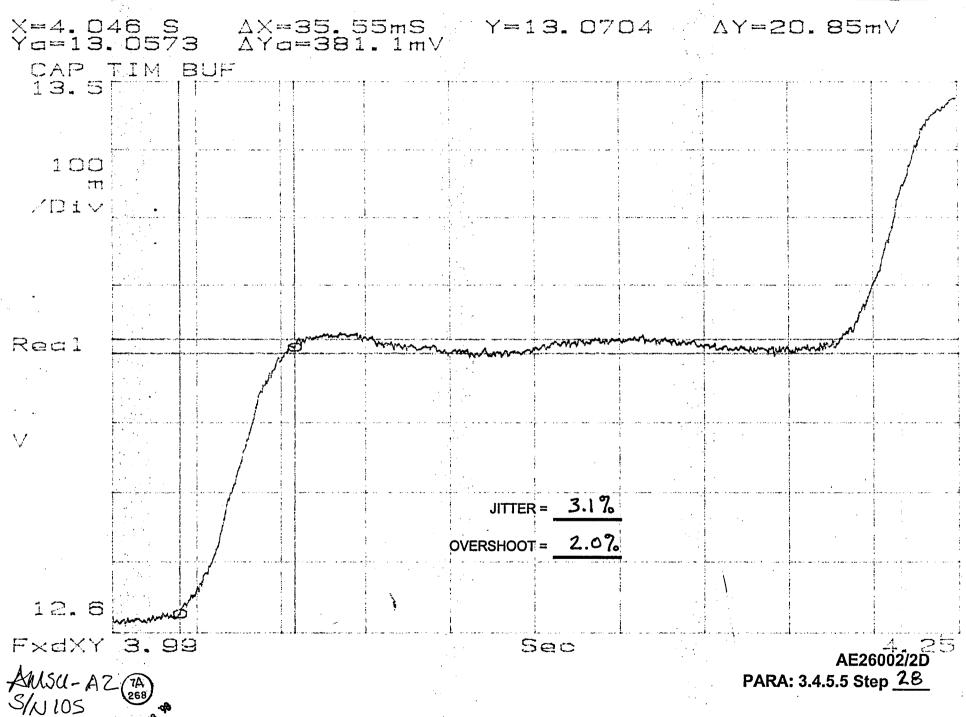


2

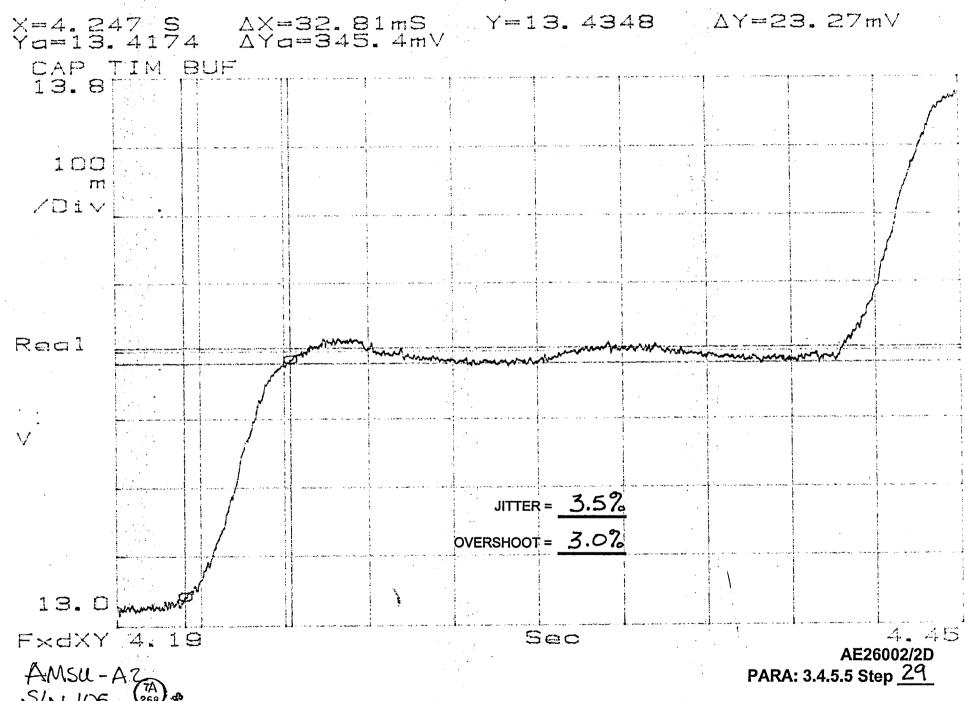
SCEN <u>49</u> FILE NAME: <u>7AP</u> FS1



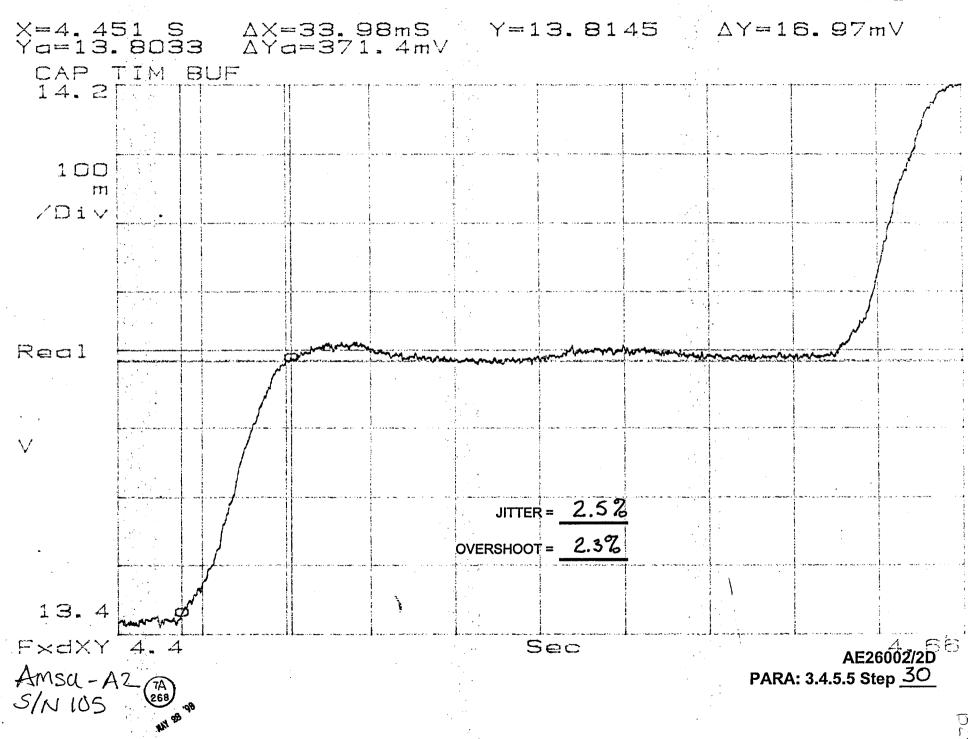
SCEN <u>LI</u> FILE NAME: <u>7AP FS1</u>



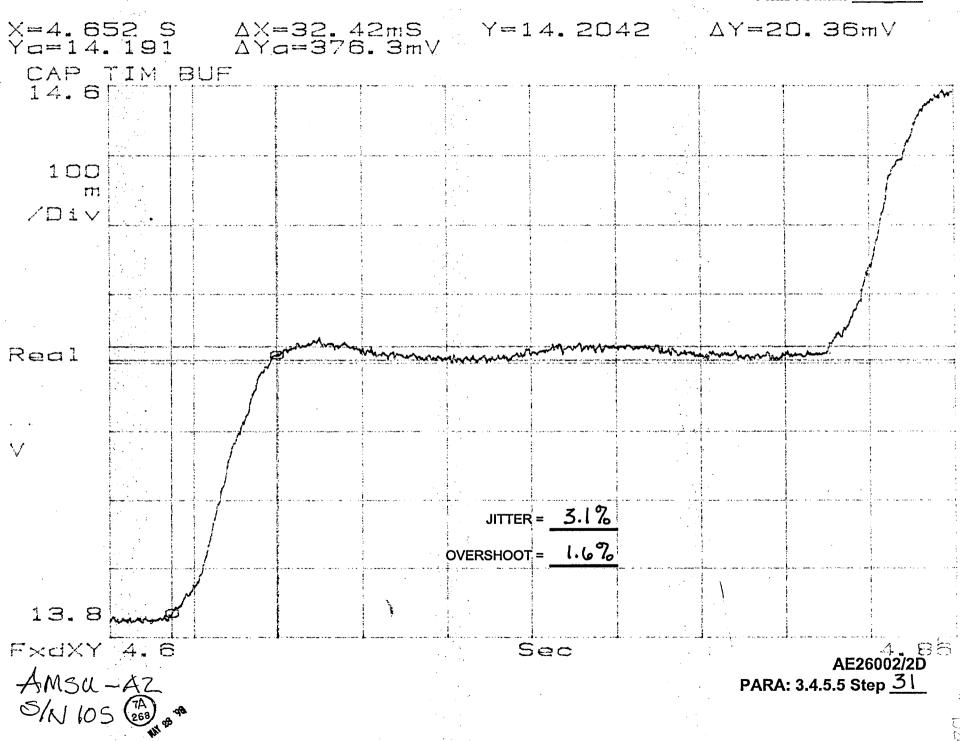
SCEN <u> ムム</u> FILE NAME: <u>7AP FS1</u>



FILE NAME: 7AP FS1



SCEN <u>24</u> FILE NAME: <u>7AP FS1</u>



<u>SΣ</u> qət2 5.5.4.5 :AЯA9 **YE**26002/2D /o 's EXGXY 4,81 295 OVERSHOOT = 2,4% \$1.8 = A3TTL Real ヘチロノ 001 o si TIM BUF 4095 \*ヤ[=P人 S セS8 \*ヤ=X \AMP=358,42m\ \AMP=328,42m\ \AMP=374,5724 △V→SB "OZ=人V FILE NAME: 7AP FS1

**SCEV** 

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47 201 LNC PARA: 3.4.5.5 Step 34 SA-NEMA **VES6002/2D** EXAXY 5.21 260 OVERSHOOT = JITTER = 4,0% Recl AFG/ JOI FILE NAME: 7AP FS1 VIIOS

901 N/S 20 - NC MA 72 q918 8.6.4.6 :AAAq AE26002jzD 단지되지 않 85 085 0.81 Sc.2 = TOOHSAEVO Real AFE/ COI 6667 9 T=PX S 898 S=X VH18.81=Y∆ 人=18"203 FILE NAME: 7AP FS1 

831 501 N/S 82 qət2 5.5.4.5 :AAAq SA-NZMA **VES000S/SD** 085 E. 19 EX9XX 2\* 68 9.31 OVERSHOOT = TOOHSAEVO AN = ABTTIL Real AICIZ **BWILMETS** 144 089 6"12 BUE AW8 "98Z=AV 96[8 "6[=A FILE NAME: 7AP FS1 **2CEV** نويه نمد

B35 A URMA. 201 Ale 82 qəj2 3.4.5.5 Step **VES0005/SD** 005 EXAXY 5, 98 4 '6I OVERSHOOT = (\$.2) 11. = ABTTIL \$ 2.5 = vm 0.65 Look PERIOD AFQ/ THIEGRAIN 15'21 8 61 CAP TIM BUF 7X=370,7ms X=19,7019 V=19, 7084 △Y=22, 0mV FILE NAME: 7AP FS1

**2CEV** 

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63. St. Co. In. P& q912 3.4.5.3 Step 3A **VE**26002/2D 29 ' 人区户区园 005 18.2 OVERSHOOT = TOOHSREYO Real ヘドロノ 22.22 SLEW TIME SNC0097 36,0 WII BUF \ E9 [[=P\\ Smo [004=\\ X=e, 9, 8511 X=6, 662 S SISO \*IE=人 VMI "S88= YA □ FILE NAME: 7AP FS1

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B34

# TEST DATA SHEET 7 (SHEET 1 OF 4) 3.4.4.5: Scan Motion and Jitter Test 5

Test Setup Verified: for the Signature

Shop Order No. 484113

Step No.	Description	Requirement	Test Result	Pass/Fail
7		Stepping Slewing <8 sec period per Figure & 8	< 8 Sec	PASS
9	Scene 1-2 3.33° step	<42 msec rise time per Figure 7 9	38,7ms	PASS
		< ±5% jitter per Figure 7.9 < +4% overshoot for 19 msec	3.6% j.t./1.6% ow	PASS
10	Scene 2-3 3.33° step	<42 msec rise time per Figure ₹9	36.3ms	PASS
	·	< ±5% jitter per Figure 79 < +4% overshoot for 19 msec	3.4% j.t / 1.4% our	PASS
11	Scene 3-4 3.33° step	<42 msec rise time per Figure 79	32.8 ms	PASS
	·	< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	3.47j.t/1.7% our	Pass
12	Scene 4-5 3.33° step	<42 msec rise time per Figure 79	38.3 ms	PASS
	_	< ±5% jitter per Figure 70 < +4% overshoot for 19 msec	2.32j.t/2.42 ovr	PASS
13	Scene 5-6 3.33° step	<42 msec rise time per Figure 79	35.2 ms	PA 55
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	1.690j.t/ 1.6% our	PASS
14	Scene 6-7 3.33° step	<42 msec rise time per Figure 7 9	37.5 ms	TOSS
		< ±5% jitter per Figure 7° 9 < +4% overshoot for 19 msec	3.1% j.t /2.860r	1785
15	Scene 7-8 3.33° step	<42 msec rise time per Figure 79	35.9 ms	TASS
		< ±5% jitter per Figure 7°9 < +4% overshoot for 19 msec	3.38 j.t / 1.48 our	PASS
16	Scene 8-9 3.33° step	<42 msec rise time per Figure 79	33.2ms	PASS
	•	< ±5% jitter per Figure 🗝 < +4% overshoot for 19 msec	4.28 j.t / 2.8% over	PASS

Figure 7 to 9 change Signatures:

Pass = P Fail = F

Quality OE MIL



B9 (223) 5/15/98 Durbyin AE-26002/20 5 -16 Dec 97

### TEST DATA SHEET 7 (SHEET 2 OF 4) 3.4.4.5: Scan Motion and Jitter Test 5

Step No.	Description	Requirement	Test Result	Pass/Fail
17	Scene 9-10 3.33° step	<42 msec rise time per Figure 74	33.2 ms	HASS
		< ±5% jitter per Figure <b>7</b> 9 < +4% overshoot for 19 msec	3.2% jit/.8% wr	PASS
18	Scene 10-11 3.33° step	<42 msec rise time per Figure 7" 9	36.3 ms	PASS
	** **	< ±5% jitter per Figure 7 % < +4% overshoot for 19 msec	3.38 jit / 1.02 ove	PASS
19	Scene 11-12 3.33° step	<42 msec rise time per Figure 7-9	33.6ms	PASS
		< ±5% jitter per Figure ₹ 9 < +4% overshoot for 19 msec	2.970 jit/1.870 ov/	PASS
20	Scene 12-13 3.33° step	<42 msec rise time per Figure 7-9	32.8 ms	PASS
		< ±5% jitter per Figure 7 4 < +4% overshoot for 19 msec	3.670 j.t/ 2.920 vr	PASS
21	Scene 13-14 3.33° step	<42 msec rise time per Figure ₹ ⊀	37.9 MS	PASS
•		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	2.5% j.t / 2.5%ord	PASS
22	Scene 14-15 3.33° step	<42 msec rise time per Figure 7-9	33.2 MS	PASS
	·	< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	4.4% j.t / 2.320ur	FASS
23	Scene 15-16 3.33° step	<42 msec rise time per Figure 7 9	37.5 ms	PASS
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	3.4% jit / 2.3% ovr	PASS
24	Scene 16-17 3.33° step	<42 msec rise time per Figure 7-9	33.2 ms	PASS
		< ±5% jitter per Figure 7- 9 < +4% overshoot for 19 msec	3.3% j.t/20% our	<del>T</del> ASS

Figure 7 to 9 change Signatures: TE 10m Hum 5/18/48

Pass = P

Fail = F





E35-3

# TEST DATA SHEET 7 (SHEET 3 OF 4) 3.4.4.5: Scan Motion and Jitter Test 5

Step No.	Description	Requirement	Test Result	Pass/Fai
25	Scene 17-18 3.33° step	<42 msec rise time per Figure 7-9	33.6 ms	DASS
		< ±5% jitter per Figure <b>7 9</b> < +4% overshoot for 19 msec	4.8% jit / 2.6% ovr	PASS
26	Scene 18-19 3.33° step	<42 msec rise time per Figure 7 9	32.4 ms	PASS
		< ±5% jitter per Figure <b>₹ 9</b> < +4% overshoot for 19 msec	2.670j.t/1.170 our	PASS
27	Scene 19-20 3.33° step	<42 msec rise time per Figure 7 9	31.25ms	PASS
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	4.3% jt/2.3% ON	PASS
28	Scene 20-21 3.33° step	<42 msec rise time per Figure 7 9	35 5	FASS
	·	< ±5% jitter per Figure 7 4 < +4% overshoot for 19 msec	3.1% jit / 8.0% our	PASS
29	Scene 21-22 3.33° step	<42 msec rise time per Figure 7 9	32.8·m=	CASS
	·	< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	3.5% jit /3.0% ori	PASS
30	Scene 22-23 3.33° step	<42 msec rise time per Figure 7 9	34ms	TASS.
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	2.5% jit /2.3% ovr	PASS
31	Scene 23-24 3.33° step	<42 msec rise time per Figure 7 9	32,4ms	PASS
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	3.1% it /1.6% ovi	17ASS
32	Scene 24-25 3.33° step	<42 msec rise time per Figure 7 9	32.4ms	TASS
	•	< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	3.180jit /2.480vs	HASS

Figure 7 to 9 change Signatures:

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13,000

Pass = P Fail = F

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# TEST DATA SHEET 7 (SHEET 4 OF 4) 3.4.4.5: Scan Motion and Jitter Test 5

635-6

Step No.	Description	Requirement	Test Result	Pass/Fail
33	Scene 25-26 3.33° step	<42 msec rise time per Figure 7 9	33.6 ms	PA35
	•	< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	4.0% j.t/1.4% on	PASS
34	Scene 26-27 3.33° step	<42 msec rise time per Figure 7 9	33.6ms	TASS
		< ±5% jitter per Figure 7 4 < +4% overshoot for 19 msec	4.0% it /3.2% ONT	PASS
35	Scene 27-28 3.33° step	<42 msec rise time per Figure 7 9	33.6ms	HASS
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	3.66 j. 3.2% our	TASS
36	Scene 28-29 3.33° step	<42 msec rise time per Figure 7 9	37.1 ms	PASS
	·	< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	4.18jt/3.98 ovr	PASS
37	Scene 29-30 3.33° step	<42 msec rise time per Figure 7 9	33.2 ms	PASS
		< ±5% jitter per Figure 7 9 < +4% overshoot for 19 msec	2.82jt/3.5%ovr	PASS
38	Scene 30 Cold Cal	<0.21 sec slew time per Figure 20 A 12	<.210 sec	PASS
Ì	35.0° slew	< ±0.165° jitter per Figure おかわる	fiç °011.	PASS
39	Cold Cal - Warm Cal	<0.40 sec slew time per Figure 개 知나	< 400 sec	TASS
	96.67° slew	< ±0.165° jitter per Figure 22 X IS	.093° j.t	FAS)

Figure 7, 10, 11, and 12 to 9, Change Signatures:

TE The Define 5/18/48

Pass = P

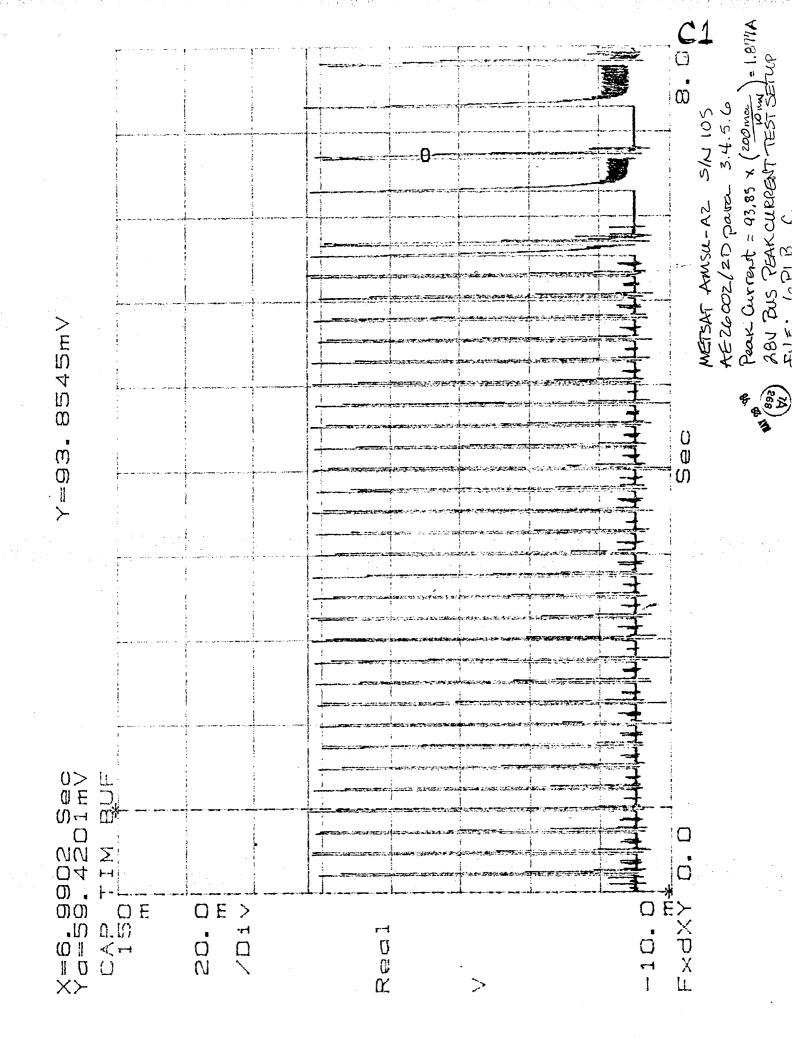
Fail = F

Assmana

Unit: METSAT AMSU-AZ	Test Engineer: Thu Dan
Serial No.: 105	Quality Assurance:
Date: 5/19/98	Customer Representative:

QC 223

12



### **TEST DATA SHEET 8** 3.4.4.6: Pulse Load Bus Current 5

Test Setup Verified:

Shop Order No. <u>484113</u>

3.4.4.6: 28V Bus Peak Current and Rise Time Test

Step No.	Requirement	Test Result	Pass/Fail
4	< 2 A peak any place in the scan	1.877 A	PASS
5	> 70 µsec rise time, 3.33° step	1.1 ms	7ASS
6	> 70 µsec rise time, start of WC slew	72 ms 1.6 ms	PASS
6	> 70 µsec rise time, end of WC slew	Ste ms	PASS

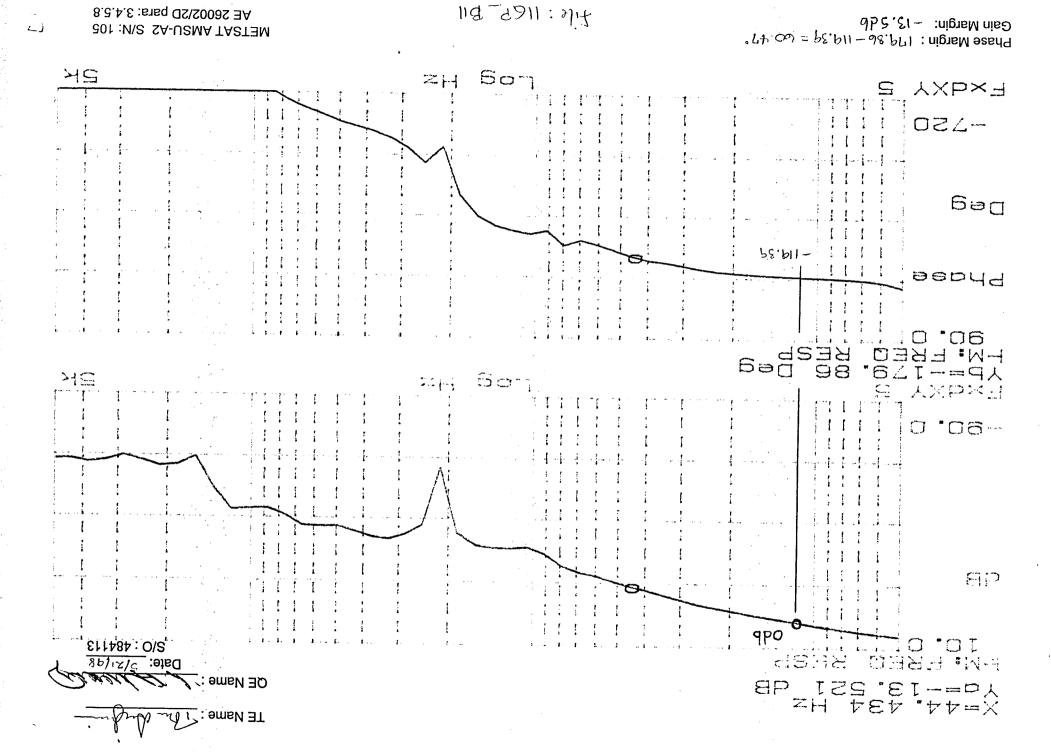
Pass = PFail = F

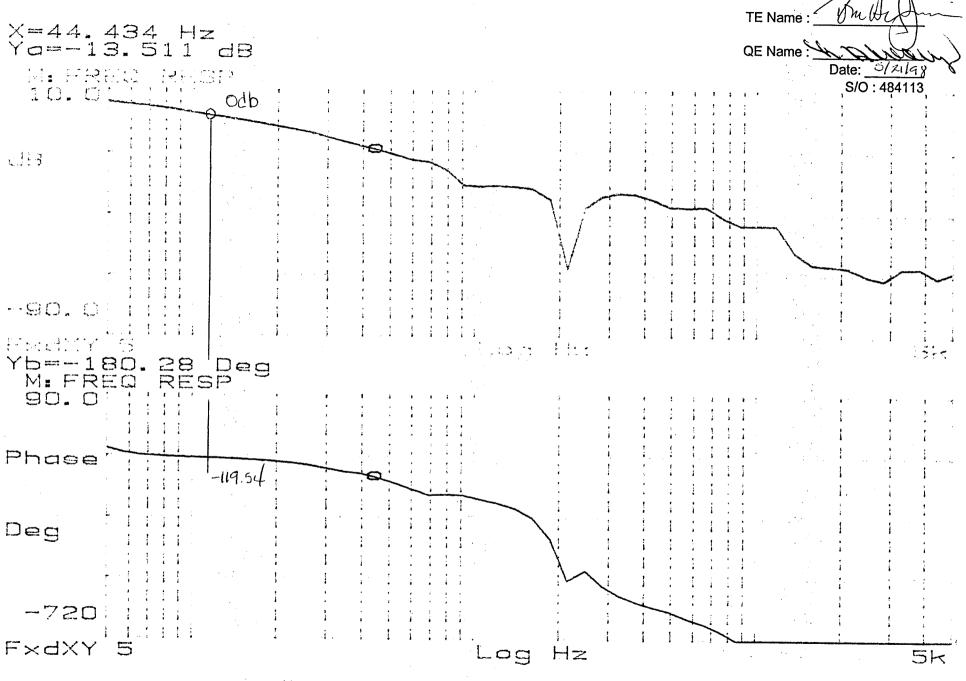
Unit:	METSAT AMSU-AZ	
Serial N	105	

Date:

Quality Assurance:

5/19/98 J



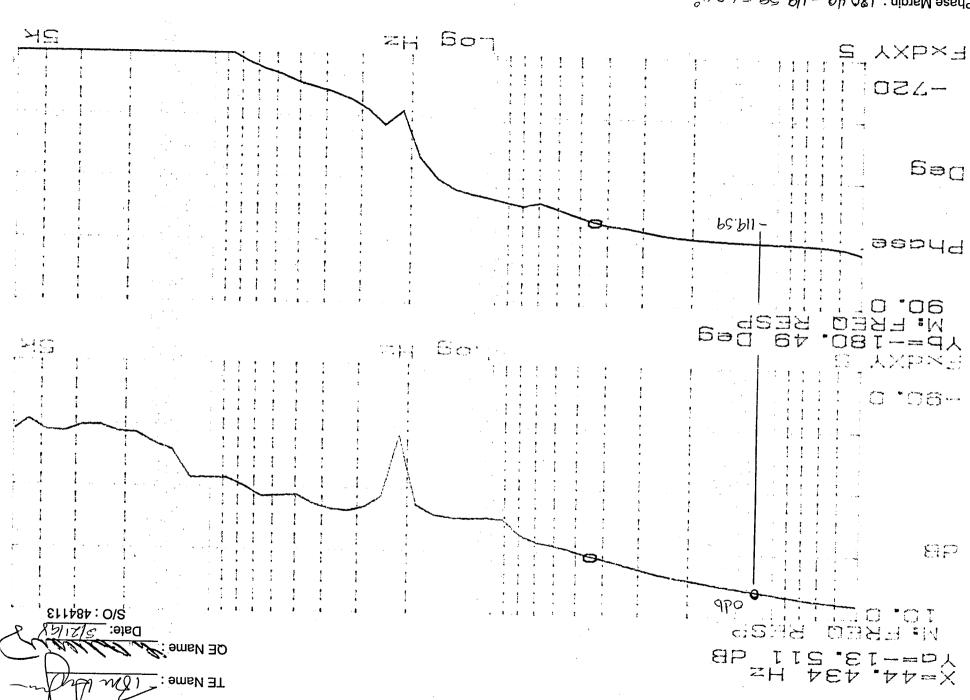


Phase Margin: 180.28 - 119.54 - 60.74

Gain Margin: -13.5 db

METSAT AMSU-A2 S/N: 105 AE 26002/2D para: 3.4.5.8

O



METSAT AMSU-A2 S/N: 105 AE 26002/2D para: 3.4.5.8 file: 1562 313

Phase Margin: 180.49 - 19.59 = 60.4° Gain Margin: -13,546 TEST DATA SHEET 9
3.4.4.8: Gain/Phase Margin Test

Test Setup Verified: 1/2

: faut ut. Lug Signature

Shop Order No. <u>48413</u>

Temperature: 7/.3°°C

3.4.4.8 Step 12: Gain/Phase Margin Test

Requirement	uirement Test Result		Pass/Fail
	1	-13.5	
	2	-13.5	7
12 dB minimum	3	-13.5	PASS
	-4		
	-5-		
	1	60.5	
	2	60.7	] _
25 degrees minimum	3	60.9	PASS
	A		
	5		

Pass = P Fail = F

	70	
Unit:_	METSAT AMOGEL-AZ	

Serial No.: 105

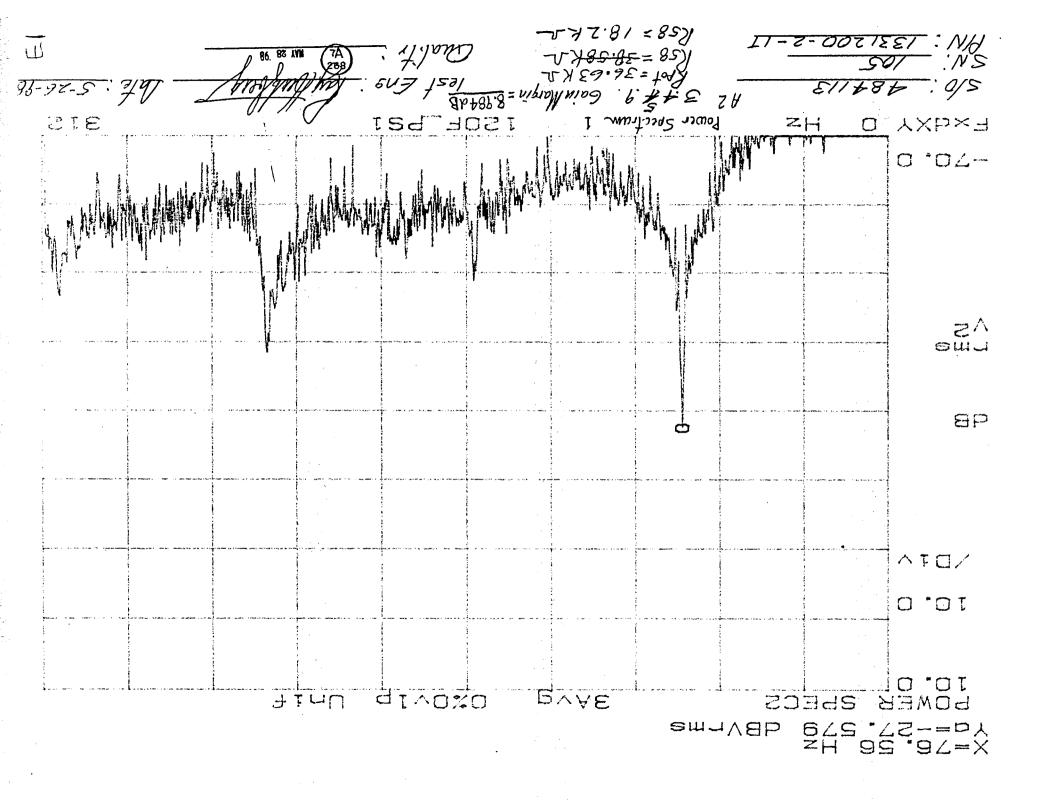
Date: 5/21/98

Test Engineer: 1 Pm &

Quality Assurance:

Customer Representative: \_\_

mn 8 x-14 Tourhigin 5/15/46



## TEST DATA SHEET 10 3.4.4.9: Operational Gain Margin Test

		//	
Test Setup Verified:	MAY	TOKK	beld/
	(7X/	Sign	ature
	1/6	<b>-</b>	7-/-

Shop Order No. <u>484 [/3</u>

Temperature: 7/ ≥ 2°C

3.4.4.9: Operation Gain Margin Test

Step No.	Requirement		Test Result	Pass/Fail
	R58 Resistance (Kohms)			
11		1	38.58 KIL	<i>P</i>
	Test Pot Resistance (Kohms)	2	4102 KA	<i>P</i>
		3	42.88 K.s.	F
12		1	227,73 4/3	P
	Oscillation Frequency (Hz)	2	228.52 1/3	ρ
		3	228,52 Hz	7 P
		1	9.277 28	P
16	Gain Margin, 9 dB minimum	2	9.6563 dB	$\square$ $\hat{\mathscr{V}}$
	,	3	9.8908 dB	<i>P</i>

Pass = P Fail = F

Unit: <u>METSAT AMSU - A2</u>
Serial No.: <u>105</u>

Test Engineer: Tay

80° 82 mm

Quality Assurance:

Date: 5-26-98

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#### **FORMS**

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7. Author(s)			Performing Organizat	ion Report No.		
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